DATA SHEET

P3C18V8Z40/P3C18V8ZIA

3 Volt zero standby power universal PAL devices

Product specification

1996 Oct 09

IC13 Data Handbook

Philips Semiconductors

PHILIPS

3 volt zero standby power universal PAL devices

P3C18V8Z40/P3C18V8ZIA

DESCRIPTION

The P3C18V8Z is a universal PAL-type device designed to operate specifically in a low voltage environment (3.3V). The PAL device is available in the commercial temperature range, P3C18V8Z40, and the industrial temperature range, P3C18V8ZIA.

These devices offer virtually zero standby power (15µA typical) as well as very low power consumption during operation. The P3C18V8Z automatically powers down when the inputs or the clock are idle for greater than one full clock cycle. The device will automatically power up from a standby mode once any input or the clock is activated. This input transition detection circuitry makes these devices ideal for power sensitive applications — especially those which are battery operated or backed up.

All the P3C18V8Z devices are available in plastic DIP, PLCC, Plastic Small Outline (SOL), Plastic Shrink Small Outline (SSOP), and Plastic Thin Shrink Small Outline (TSSOP) packages. A ceramic DIP with a window for erasure is available for prototyping.

The P3C18V8Z is a two level logic element comprised of 10 inputs, 74 AND gates (logic and control product terms) and 8 Output Macro Cells (OMCs). Each OMC can be configured as a dedicated input, a combinatorial I/O or a registered output with internal feedback. Each OMC has individual direction control (from the AND array) and programmable output polarity. The dedicated clock and OE pins can be configured as inputs for strictly combinatorial applications. Two product terms control the asynchronous Reset and the synchronous Preset functions.

Power up Reset and Register Preload functions have also been incorporated into the P3C18V8Z to facilitate state machine design and testing.

The Output Macro Cell feature of the P3C18V8Z devices provides the flexibility to emulate all 20 pin common PAL and GAL functions, thus providing reduced documentation, inventory and manufacturing costs. The P3C18V8Z is also pin and fuse map compatible with all the Philips 5 Volt PLC18V8Z devices.

FEATURES

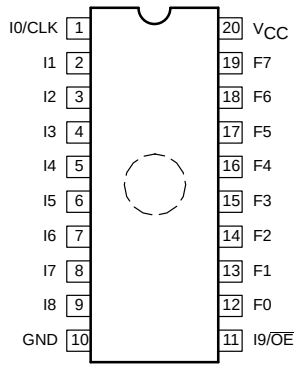
- 20-pin Universal Programmable Array Logic (PAL), operational over low voltage range and industrial temperature range
- Virtually zero-standby-power and very low dynamic power
  - 15µA standby (typ.)
  - 0.9 mA/MHz (worst case)
- Functional replacement for Series 16 PALs and GALs
  - Highly flexible Output Macro Cell
- Available in DIP, PLCC, SOL (Small Outline), SSOP (Shrink Small Outline), and TSSOP (Thin Shrink Small Outline) packages
- High performance EPROM CMOS cell technology
  - 100% testable prior to programming
  - Low cost OTP plastic packages
  - Erasable/reconfigurable (ceramic package)
- Design support provided by most popular third party programmable Logic CAD tools

APPLICATIONS

- Laptop, notebook and palm top computers
- Portable communications equipment
- Battery powered instruments
- Industrial automation/control

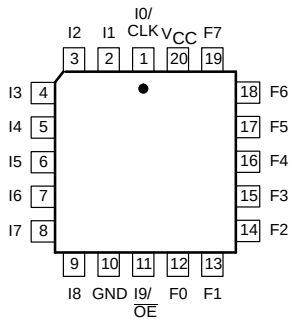
PIN CONFIGURATIONS

D, DB, DH, N, and FA Packages



D = Plasitc Small Outline Large Package (300mil-wide)
DB = Plastic Shrink Small Outline Package (5.3mm wide)
DH = Plastic Thin Shrink Small Outline Package (4.4mm wide)
N = Plastic Dual In-Line Package (DIP) (300mil-wide)
FA = Ceramic DIP with Quartz Window (300mil-wide)

A Package



A = Plastic Leaded Chip Carrier

SP00026A

PIN DESCRIPTIONS

I	Dedicated Input
F	Output/Input Macrocell
CLK	Clock Input
$\overline{OE}$	Output Enable
V_{CC}	Supply Voltage
GND	Ground

ORDERING INFORMATION

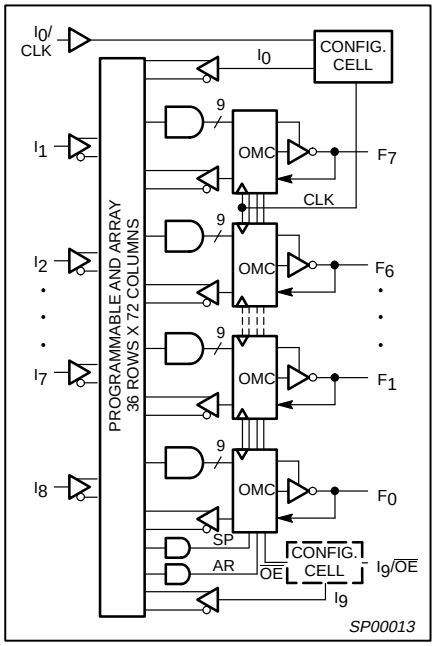
DESCRIPTION	TEMPERATURE RANGE	ORDER CODE	DRAWING NUMBER
20-Pin (300mil-wide) Plastic Dual In-Line Package	Commercial	P3C18V8Z40N	SOT146-1
20-Pin (300mil-wide) Ceramic Dual In-Line Package with Quartz Window		P3C18V8Z40FA	0584B
20-Pin (350mil square) Plastic Leaded Chip Carrier Package		P3C18V8Z40A	SOT380-1
20-Pin (300mil-wide) Plastic Small Outline Large Package		P3C18V8Z40D	SOT163-1
20-Pin (5.3mm-wide) Plastic Shrink Small Outline Package		P3C18V8Z40DB	SOT339-1
20-Pin (4.4mm-wide) Plastic Thin Shrink Small Outline Package		P3C18V8Z40DH	SOT360-1
20-Pin (300mil-wide) Plastic Dual In-Line Package	Industrial	P3C18V8ZIAN	SOT146-1
20-Pin (300mil-wide) Ceramic Dual In-Line Package with quartz window		P3C18V8ZIAFA	0584B
20-Pin (350mil square) Plastic Leaded Chip Carrier Package		P3C18V8ZIAA	SOT380-1
20-Pin (300mil-wide) Plastic Small Outline Large Package		P3C18V8ZIAD	SOT163-1
20-Pin (5.3mm-wide) Plastic Shrink Small Outline Package		P3C18V8ZIADB	SOT339-1
20-Pin (4.4mm-wide) Plastic Thin Shrink Small Outline Package		P3C18V8ZIADH	SOT360-1

PAL DEVICE TO P3C18V8Z OUTPUT PIN CONFIGURATION CROSS REFERENCE

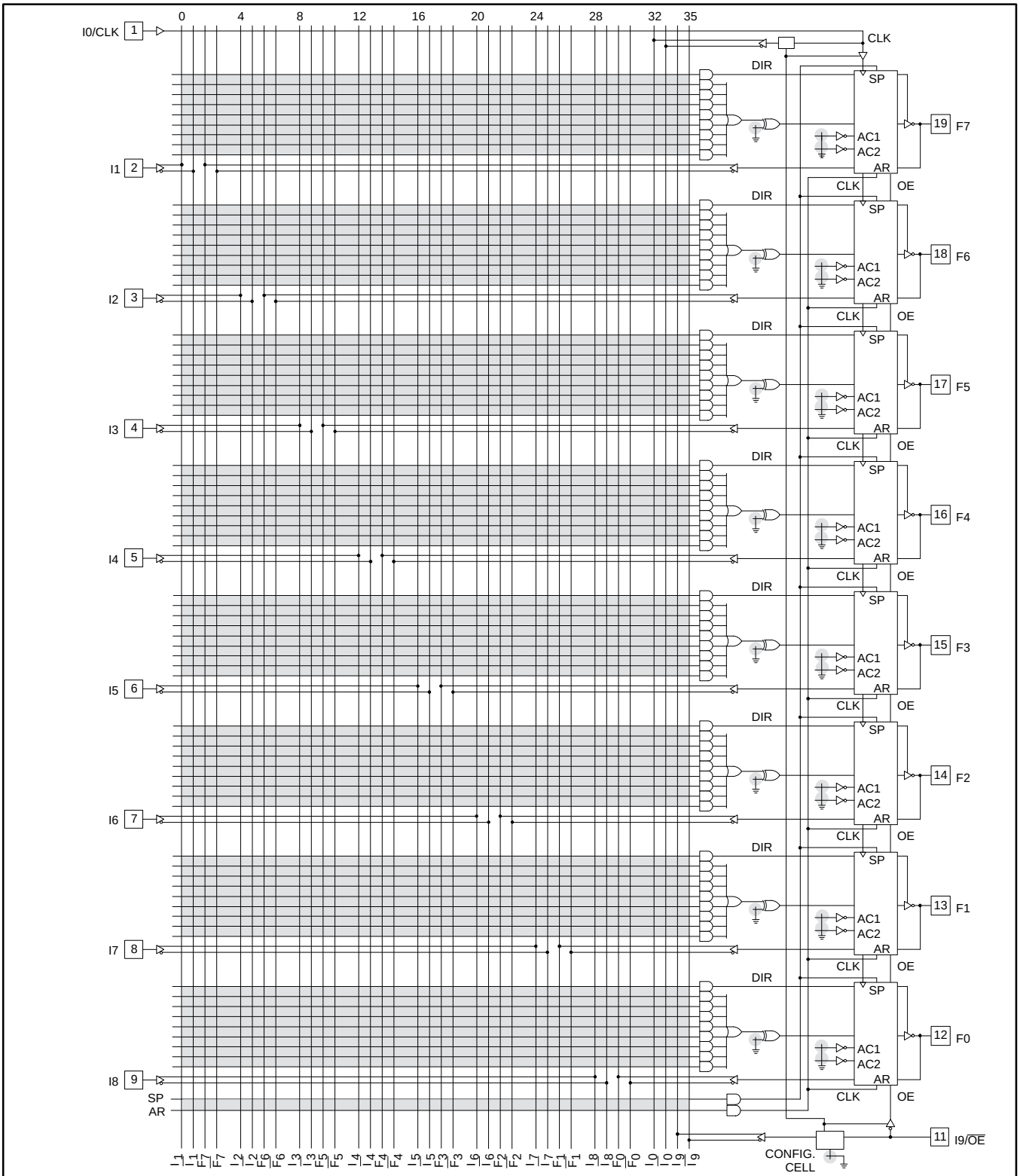
PIN NO.	P3C 18V8Z	16L8 16H8 16P8 16P8	16R4 16RP4	16R6 16RP6	16R8 16RP8	16L2 16H2 16P2	14L4 14H4 14P4	12L6 12H6 12P6	10L8 10H8 10P8
1	I_0/CLK	I	CLK	CLK	CLK	I	I	I	I
19	F7	B	B	B	D	I	I	I	O
18	F6	B	B	D	D	I	I	O	O
17	F5	B	D	D	D	I	O	O	O
16	F4	B	D	D	D	O	O	O	O
15	F3	B	D	D	D	O	O	O	O
14	F2	B	D	D	D	I	O	O	O
13	F1	B	B	D	D	I	I	O	O
12	F0	B	B	B	D	I	I	I	O
11	$I_9/\overline{OE}$	I	$\overline{OE}$	$\overline{OE}$	$\overline{OE}$	I	I	I	I

The Philips Semiconductors' state-of-the-art Floating-Gate CMOS EPROM process yields bipolar equivalent performance at less than one-quarter the power consumption. The erasable nature of the EPROM process enables Philips Semiconductors to functionally test the devices prior to shipment to the customer. Additionally, this allows Philips Semiconductors to extensively stress test, as well as ensure the threshold voltage of each individual EPROM cell. 100% programming yield is subsequently guaranteed.

FUNCTIONAL DIAGRAM



LOGIC DIAGRAM



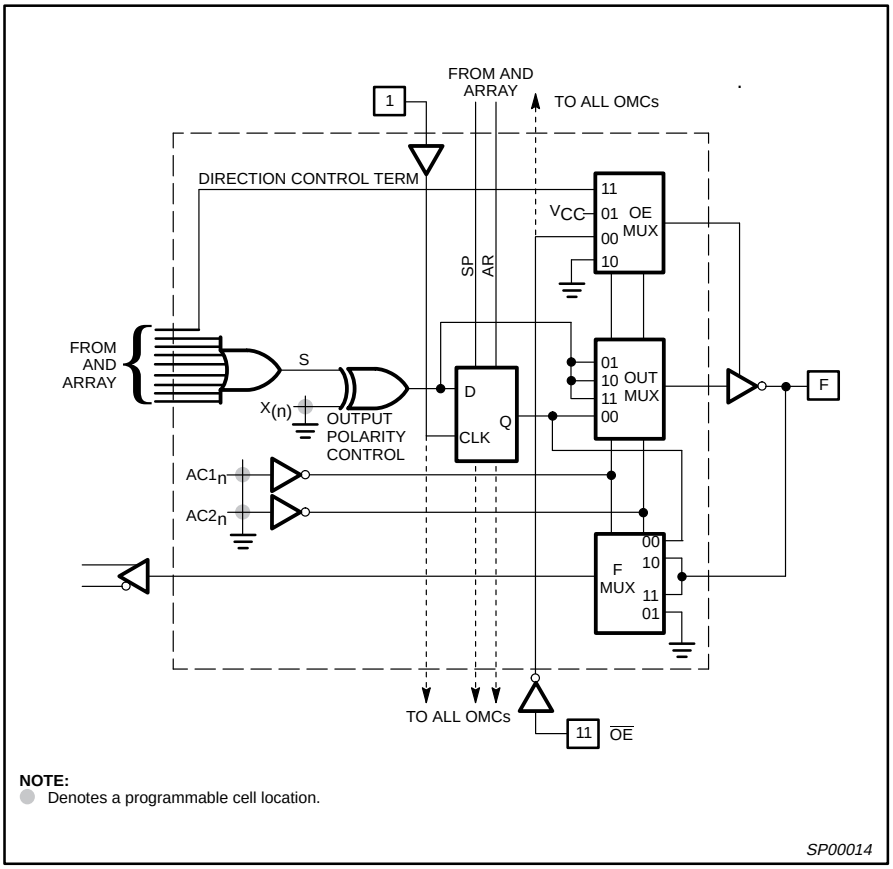
NOTES:
In the unprogrammed or virgin state:

All cells are in a conductive state.
All AND gate locations are pulled to a logic "0" (Low).
Output polarity is inverting.

Pins 1 and 11 are configured as Inputs 0 and 9, respectively, via the configuration cell. The clock and $\overline{OE}$ functions are disabled.
All output macro cells (OMC) are configured as bidirectional I/O, with the outputs disabled via the direction term.
Denotes a programmable cell location.

SP00012

OUTPUT MACRO CELL (OMC)



THE OUTPUT MACRO CELL (OMC)

The P3C18V8Z series devices have 8 individually programmable Output Macro Cells. The 72 AND inputs (or product terms) from the programmable AND array are connected to the 8 OMCs in groups of 9. Eight of the AND terms are dedicated to logic functions; the ninth is for asynchronous direction control, which enables/disables the respective bidirectional I/O pin. Two product terms are dedicated for the Synchronous Preset and Asynchronous Reset functions.

Each OMC can be independently programmed via 16 architecture control bits, $AC1_n$ and $AC2_n$ (one pair per macro cell). Similarly, each OMC has a programmable output polarity control bit (Xn). By configuring the pair of architecture control bits according to the configuration cell table, 4 different configurations may be implemented. Note that the configuration cell is automatically programmed based on the OMC configuration.

DESIGN SECURITY

The P3C18V8Z series devices have a programmable security fuse that controls the access to the data programmed in the device. By using this programmable feature, proprietary designs implemented in the device cannot be copied or retrieved.

CONFIGURATION CELL

A single configuration cell controls the functions of Pins 1 and 11. Refer to Functional Diagram. When the configuration cell is programmed, Pin 1 is a dedicated clock and Pin 11 is dedicated for output enable. When the configuration cell is unprogrammed, Pins 1 and 11 are both dedicated inputs. Note that the output enable for all registered OMCs is common—from Pin 11 only. Output enable control of the bidirectional I/O OMCs is provided from the AND array via the direction product term.

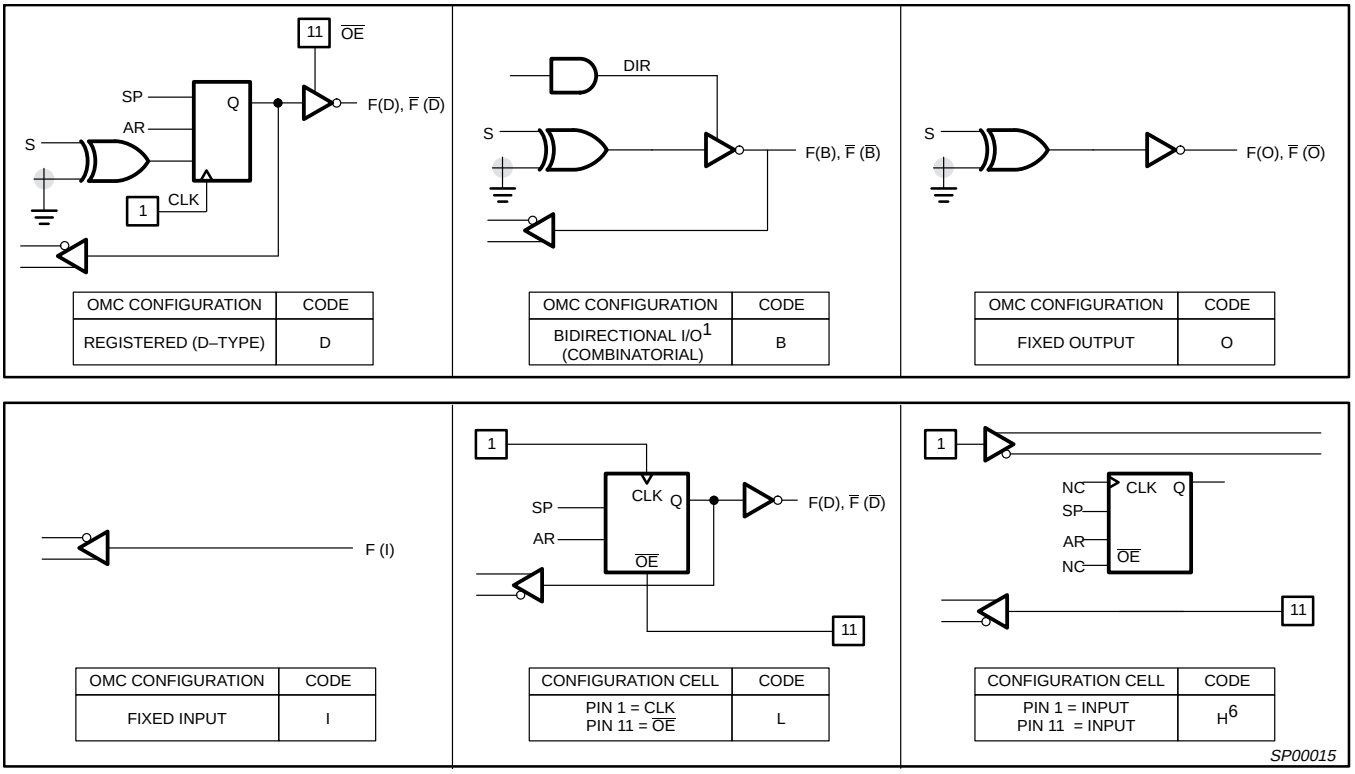
If any one OMC is configured as registered, the configuration cell will be automatically configured (via the design software) to ensure that the clock and output enable functions are enabled on Pins 1 and 11, respectively. If none of the OMCs are registered, the configuration cell will be programmed such that Pins 1 and 11 are dedicated inputs. The programming codes are as follows:

Pin 1 = CLK, Pin 11 = $\overline{OE}$	L
Pin 1 and Pin 11 = Input	H

FUNCTION	CONTROL CELL CONFIGURATIONS			COMMENTS
	$AC1_1$	$AC2_N$	CONFIG. CELL	
Registered mode	Programmed	Programmed	Programmed	Dedicated clock from Pin 1. $\overline{OE}$ Control for all registerd OMCs from Pin 11 only.
Bidirectional I/O mode	Unprogrammed	Unprogrammed	Unprogrammed	Pins 1 and 11 are dedicated inputs. 3-State control from AND array only.
Fixed input mode	Unprogrammed	Programmed	Unprogrammed	Pins 1 and 11 are dedicated inputs.
Fixed output mode	Programmed	Unprogrammed	Unprogrammed	Pins 1 and 11 are dedicated inputs. The feedback path (via F_{MUX}) is disabled.

NOTE:
1. This is the virgin state as shipped from the factory.

ARCHITECTURE CONTROL—AC1 and AC2



OMC CONFIGURATION	CODE
REGISTERED (D–TYPE)	D

OMC CONFIGURATION	CODE
BIDIRECTIONAL I/O[1] (COMBINATORIAL)	B

OMC CONFIGURATION	CODE
FIXED OUTPUT	O

OMC CONFIGURATION	CODE
FIXED INPUT	I

CONFIGURATION CELL	CODE
PIN 1 = CLK PIN 11 = $\overline{OE}$	L

CONFIGURATION CELL	CODE
PIN 1 = INPUT PIN 11 = INPUT	H[6]

NOTES:
A factory shipped unprogrammed device is configured such that:
1. This configuration cannot be used if any OMCs are configured as registered (Code = D). The configuration cell will be automatically configured to ensure that the clock and output enable functions are enabled on Pins 1 and 11, respectively, if any one OMC is programmed as registered.
   * All AND gates are pulled to a logic ”0” (Low).
   * Output polarity is inverting.
   * Pins 1 and 11 are configured as inputs 0 and 9. The clock and OE functions are disabled.
   * All Output Macro Cells (OMCs) are configured as bidirectional I/O, with the outputs disabled via the direction term.

ABSOLUTE MAXIMUM RATINGS[1]

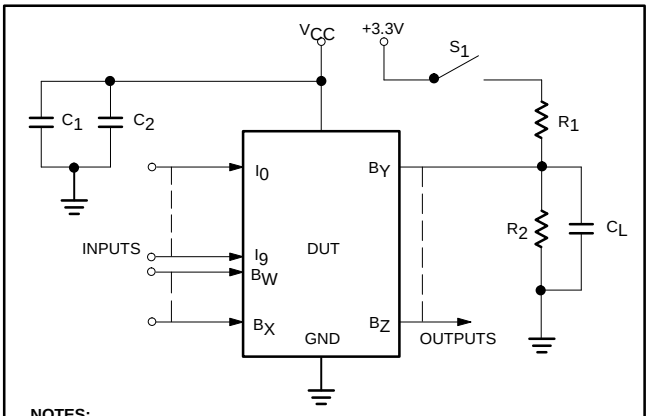
SYMBOL	PARAMETER	RATINGS	UNIT
V_{CC}	Supply voltage	–0.5 to +6	V_{DC}
V_{CC}	Operating supply voltage	3.0 to 3.6	V_{DC}
V_{IN}	Input voltage	–0.5 to V_{CC} +0.5	V_{DC}
V_{OUT}	Output voltage	–0.5 to V_{CC} +0.5	V_{DC}
$\Delta t/\Delta V$	Input/clock transition rise or fall[2]	200	ns/V maximum
I_{IN}	Input currents	–10 to +10	mA
I_{OUT}	Output currents	+24	mA
T_{amb}	Operating temperature range	–40 to +85 (Industrial) 0 to +75 (Commercial)	°C
T_{stg}	Storage temperature range	–65 to +150	°C

NOTES:
1. Stresses above those listed may cause malfunction or permanent damage to the device. This is a stress rating only. Functional operation at these or any other condition above those indicated in the operational and programming specification of the device is not implied.
2. All digital circuits can oscillate or trigger prematurely when input rise and fall times are very long. When the input signal to a device is at or near the switching threshold, noise on the line will be amplified and can cause oscillation which, if the frequency is low enough, can cause subsequent stages to switch and give erroneous results. For this reason, external Schmitt-triggers are recommended if rise/fall times are likely to exceed 200ns at V_{CC} = 3.6V.

THERMAL RATINGS

TEMPERATURE	
Maximum junction	150°C
Maximum ambient	75°C
Allowable thermal rise ambient to junction	75°C

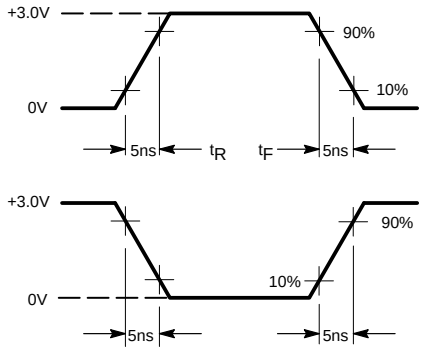
AC TEST CONDITIONS



NOTES:
C_1 and C_2 are to bypass V_{CC} to GND.
R1 = 200Ω R2 = 390Ω

SP00353

VOLTAGE WAVEFORMS

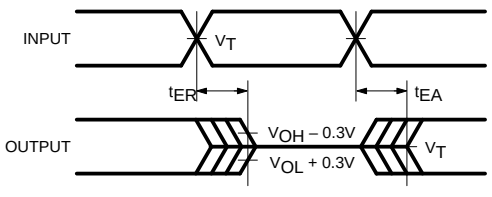


MEASUREMENTS:
All circuit delays are measured at the +1.5V level of inputs and outputs, unless otherwise specified.

Input Pulses

SP00017

SWITCHING WAVEFORM



Input to Output Disable/Enable

SP00354

DC ELECTRICAL CHARACTERISTICS

3.0V $\leq V_{CC} \leq$ 3.6 ranges
Commercial = 0°C $\leq T_{amb} \leq$ +75°C
Industrial = –40°C $\leq T_{amb} \leq$ +85°C

SYMBOL	PARAMETER	TEST CONDITION	LIMITS			UNIT
			MIN	TYP[1]	MAX	
Input voltage						
V_{IL}	Low	V_{CC} = MIN	–0.3		0.8	V
V_{IH}	High	V_{CC} = MAX	2.0		V_{CC} + 0.3	V
Output voltage[2]						
V_{OL}	Low	V_{CC} = MIN, I_{OL} = 20µA V_{CC} = MIN, I_{OL} = 24mA			0.100 0.500	V V
V_{OH}	High	V_{CC} = 3.0, I_{OH} = –3.2mA V_{CC} = 3.0, I_{OH} = –20µA V_{CC} = 3.0, I_{OH} = –1.6µA	V_{CC} – 0.6 V_{CC} – 0.3 V_{CC} – 0.3			V V
Input current						
I_{IL}	Low[5]	V_{IN} = GND			–5	µA
I_{IH}	High	V_{IN} = V_{CC}			5	µA
Output current						
$I_{O(OFF)}$	Hi–Z state	V_{OUT} = V_{CC} V_{OUT} = GND			10 –10	µA µA
I_{OS}	Short-circuit[3]	V_{OUT} = GND			–130	mA
I_{CC}	V_{CC} supply current (Standby)	V_{CC} = MAX, V_{IN} = 0 or V_{CC}[6]		15	40	µA
I_{CC}/f	V_{CC} supply current (Active)[4]	V_{CC} = MAX		.75	0.9	mA/MHz
Capacitance						
C_I	Input	V_{CC} = 5V, V_{IN} = 2.0V		12		pF
C_B	I/O	V_B = 2.0V		15		pF

NOTES:
1. All typical values are at V_{CC} = 3.3V, T_{amb} = +25°C.
2. All voltage values are with respect to network ground terminal.
3. Duration of short–circuit should not exceed one second. Test one at a time.
4. Measured with all outputs switching.
5. I_{IL} for Pin 1 (I_0/CLK) is $\pm$ 10µA with V_{IN} = 0.4V.
6. V_{IN} includes CLK and $\overline{OE}$ if applicable.

AC ELECTRICAL CHARACTERISTICS

3.0V ≤ V_{CC} ≤ 3.6V range; R_2 = 390Ω
Commercial = 0°C ≤ T_{amb} ≤ +75°C
Industrial = –40°C ≤ T_{amb} ≤ +85°C

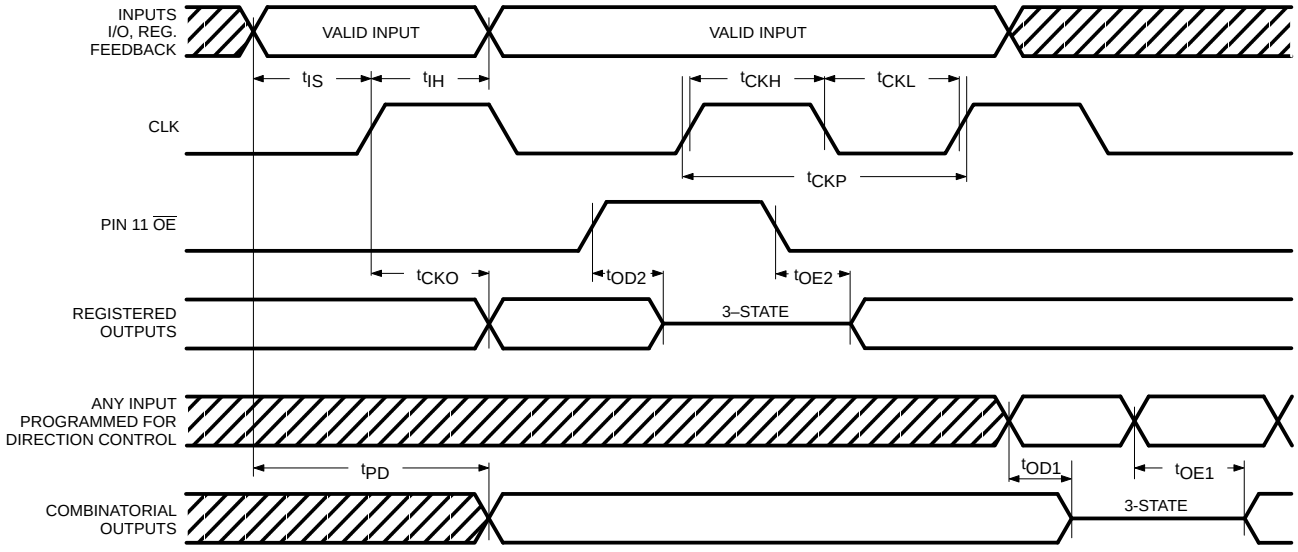
SYMBOL	PARAMETER	FROM	TO	TEST CONDITION[1]	P3C18V8Z40 (Commercial)		P3C18V8ZIA (Industrial)		UNIT
				C_L (pF)	MIN	MAX	MIN	MAX	
Pulse width									
t_{CKP}	Clock period (Minimum $t_{IS} + t_{CKO}$)	CLK +	CLK +	50	47		57		ns
t_{CKH}	Clock width High	CLK +	CLK –	50	20		25		ns
t_{CKL}	Clock width Low	CLK –	CLK +	50	20		25		ns
t_{ARW}	Async reset pulse width	I ±, F±	I $\overline{+}$, F $\overline{+}$		35		40		ns
Hold time									
t_{IH}	Input or feedback data hold time	CLK +	Input ±	50	0		0		ns
Setup time									
t_{IS}	Input or feedback data setup time	I ±, F±	CLK +	50	30		35		ns
Propagation delay									
t_{PD}	Delay from input to active output	I ±, F±	F±	50		40		45	ns
t_{CKO}	Clock High to output valid access Time	CLK +	F±	50		15		20	ns
t_{OE1}	Product term enable to outputs off	I ±, F±	F±	50		40		45	ns
t_{OD1}	Product term disable to outputs off	I ±, F±	F±	5		40		45	ns
t_{OD2}	Pin 11 output disable High to outputs off	OE –	F±	5		25		30	ns
t_{OE2}	Pin 11 output enable to active output	OE +	F±	50		30		35	ns
t_{ARD}	Async reset delay	I ±, F±	F +			40		45	ns
t_{ARR}	Async reset recovery time	I ±, F±	CLK +		30		35		ns
t_{SPR}	Sync preset recovery time	I ±, F±	CLK +		30		35		ns
t_{PPR}	Power-up reset	V_{CC} +	F +			35		40	ns
Frequency of operation									
f_{MAX}	Maximum frequency	$1/(t_{IS} + t_{CKO})$		50		22		18	MHz

NOTES:
1. Refer also to AC Test Conditions. (Test Load Circuit)

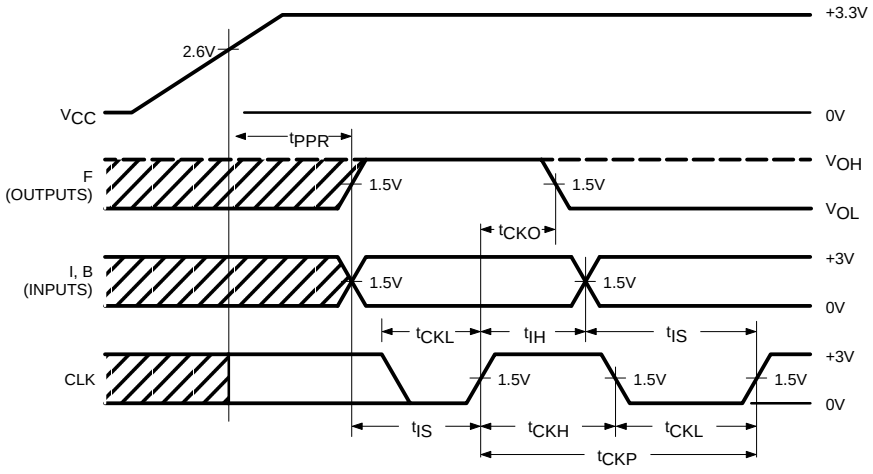
POWER-UP RESET

In order to facilitate state machine design and testing, a power-up reset function has been incorporated in the P3C18V8Z. All internal registers will reset to Active-Low (logical “0”) after a specified period of time (t_{PPR}). Therefore, any OMC that has been configured as a registered output will always produce an Active-High on the associated output pin because of the inverted output buffer. The internal feedback (Q) of a registered OMC will also be set Low. The programmed polarity of OMC will not affect the Active-High output condition during a system power-up condition.

TIMING DIAGRAMS



Switching Waveforms

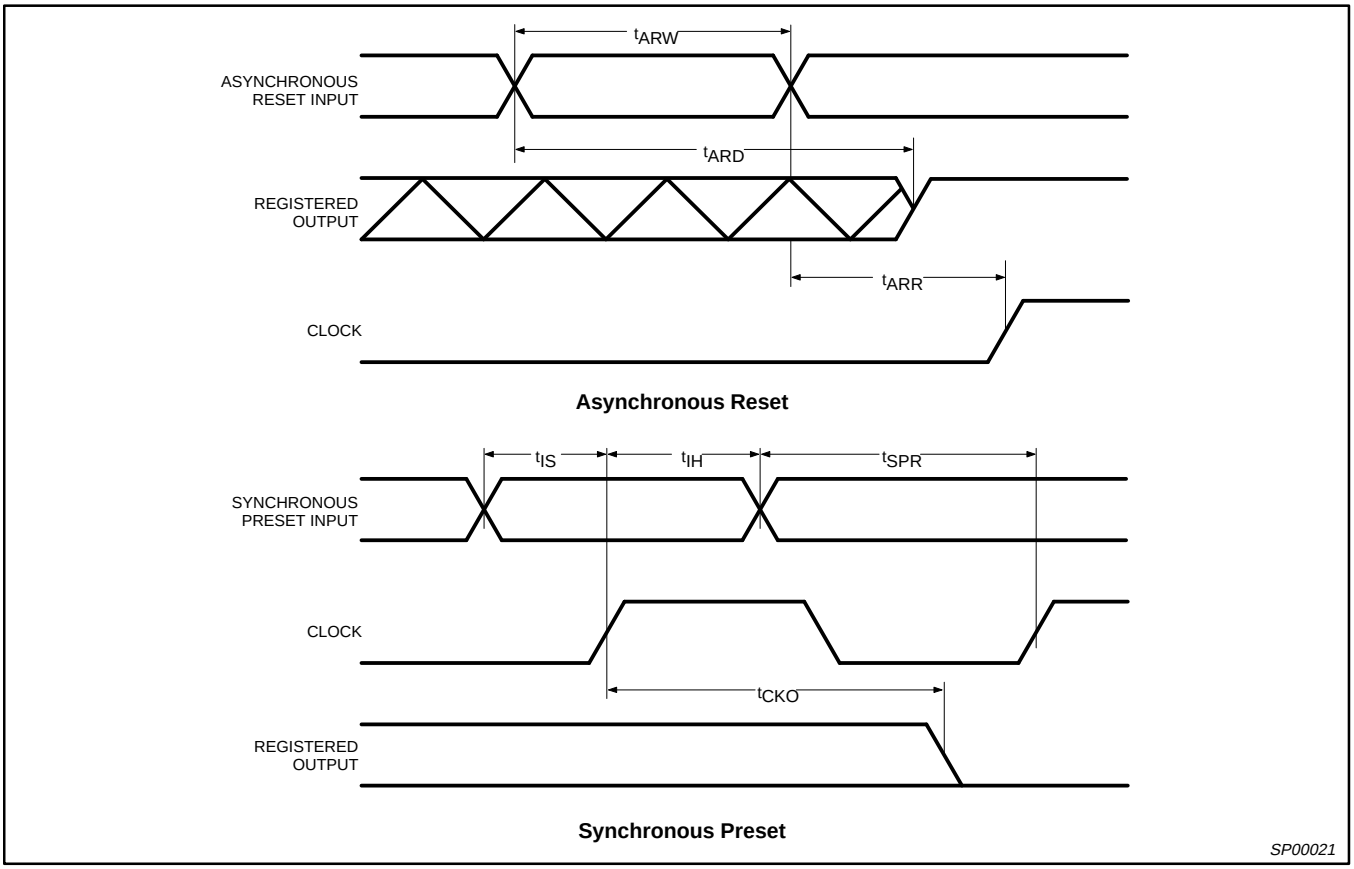


NOTE:
Diagram presupposes that the outputs (F) are enabled. The reset occurs regardless of the output condition (enabled or disabled).

Power-Up Reset

SP00356

TIMING DIAGRAMS (Continued)



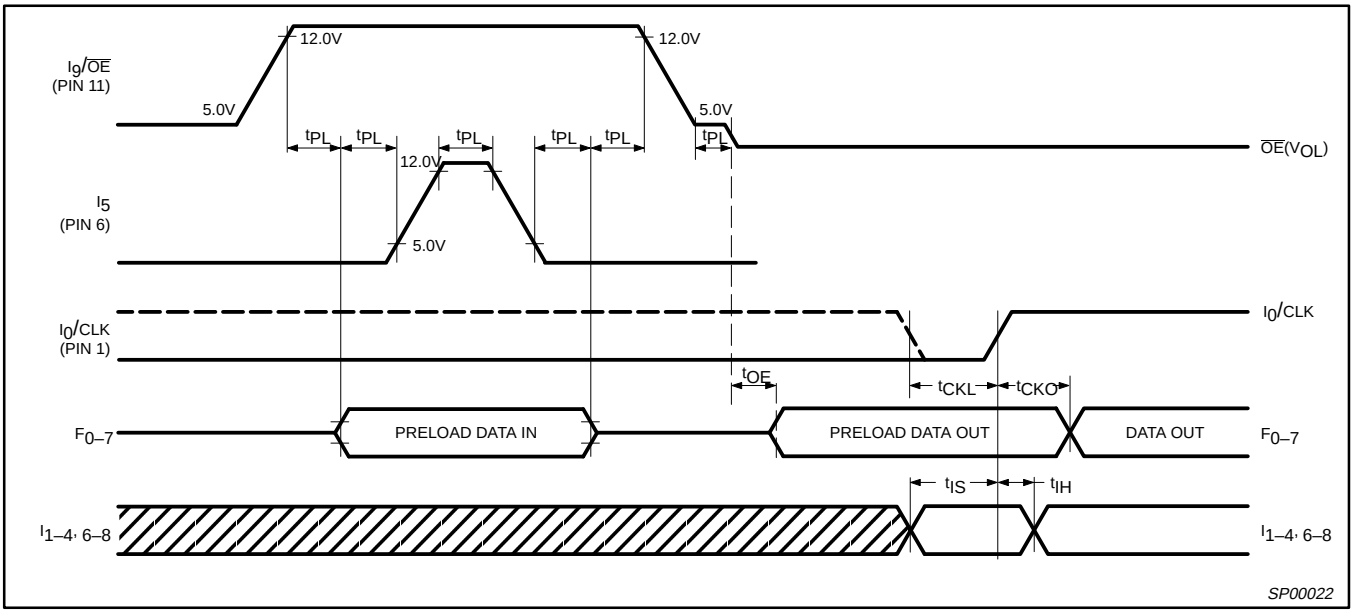
REGISTER PRELOAD FUNCTION (DIAGNOSTIC MODE ONLY)

In order to facilitate the testing of state machine/controller designs, a diagnostic mode register preload feature has been incorporated into the P3C18V8Z series device. This feature enables the user to load the registers with predetermined states while a super voltage is applied to Pins 11 and 6 ($I_9/\overline{OE}$ and I_5). (See diagram for timing and sequence.)

To read the data out, Pins 11 and 6 must be returned to normal TTL levels. The outputs, F_{0-7}, must be enabled in order to read data out. The Q outputs of the registers will reflect data in as input via F_{0-7} during preload. Subsequently, the register Q output via the feedback path will reflect the data in as input via F_{0-7}.

Refer to the voltage waveform for timing and voltage references. t_{PL} = 10µsec.

REGISTER PRELOAD (DIAGNOSTIC MODE)



LOGIC PROGRAMMING

The P3C18V8Z series is fully supported by industry standard (JEDEC compatible) PLD CAD tools, including Philips Semiconductors' SNAP design software package. ABEL™ and CUPL™ 90 design software packages also support the P3C18V8Z architecture.

All packages allow Boolean and state equation entry formats. SNAP, ABEL and CUPL also accept, as input, schematic capture format.

P3C18V8Z logic designs can also be generated using the program table entry format, which is detailed on the following pages. This program table entry format is supported by SNAP only.

With Logic programming, the AND/OR/EX-OR gate input connections necessary to implement the desired logic function are coded directly from logic equations using the Program Table. Similarly, various OMC configurations are implemented by programming the Architecture Control bits AC1 and AC2. Note that the configuration cell is automatically programmed based on the OMC configuration.

In this table, the logic state of variables I, P and B associated with each Sum Term S is assigned a symbol which results in the proper fusing pattern of corresponding link pairs, defined as follows:

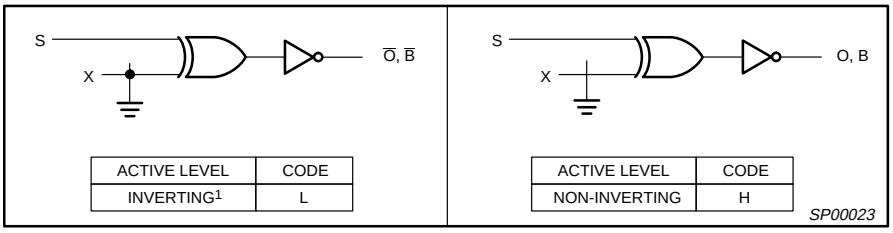
ERASURE CHARACTERISTICS (For Quartz Window Packages Only)

The erasure characteristics of the P3C18V8Z Series devices are such that erasure begins to occur upon exposure to light with wavelengths shorter than approximately 4000 Angstroms (Å). It should be noted that sunlight and certain types of fluorescent lighting could erase a typical P3C18V8Z in approximately three years, while it would take approximately one week to cause erasure when exposed to direct sunlight. If the P3C18V8Z is to be exposed to these types of lighting conditions for extended periods of time, opaque labels should be placed over the window to prevent unintentional erasure.

The recommended erasure procedure for the P3C18V8Z is exposure to shortwave ultraviolet light which has a wavelength of 2537 Angstroms (Å). The integrated dose (i.e., UV intensity × exposure time) for erasure should be a minimum of 15Wsec/cm^2. The erasure time with this dosage is approximately 30 to 35 minutes using an ultraviolet lamp with a 12,000µW/cm^2 power rating. The device should be placed within one inch of the lamp tubes during erasure. The maximum integrated dose a CMOS EPLD can be exposed to without damage is 7258Wsec/cm^2). Exposure of these CMOS EPLDs to high intensity UV light for longer periods may cause permanent damage.

The maximum number of guaranteed erase/write cycles is 50. Data retention exceeds 20 years.

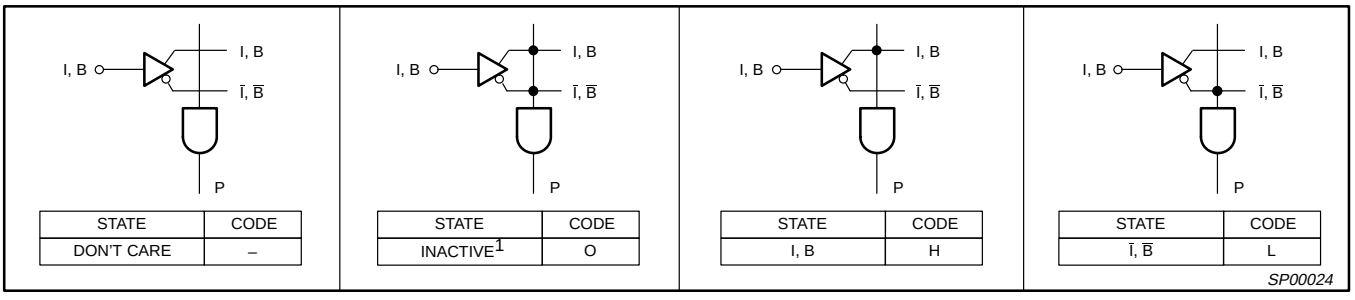
OUTPUT POLARITY – (O, B)



ACTIVE LEVEL	CODE
INVERTING[1]	L

ACTIVE LEVEL	CODE
NON-INVERTING	H

"AND" ARRAY – (I, B)



STATE	CODE
DON'T CARE	–

STATE	CODE
INACTIVE[1]	O

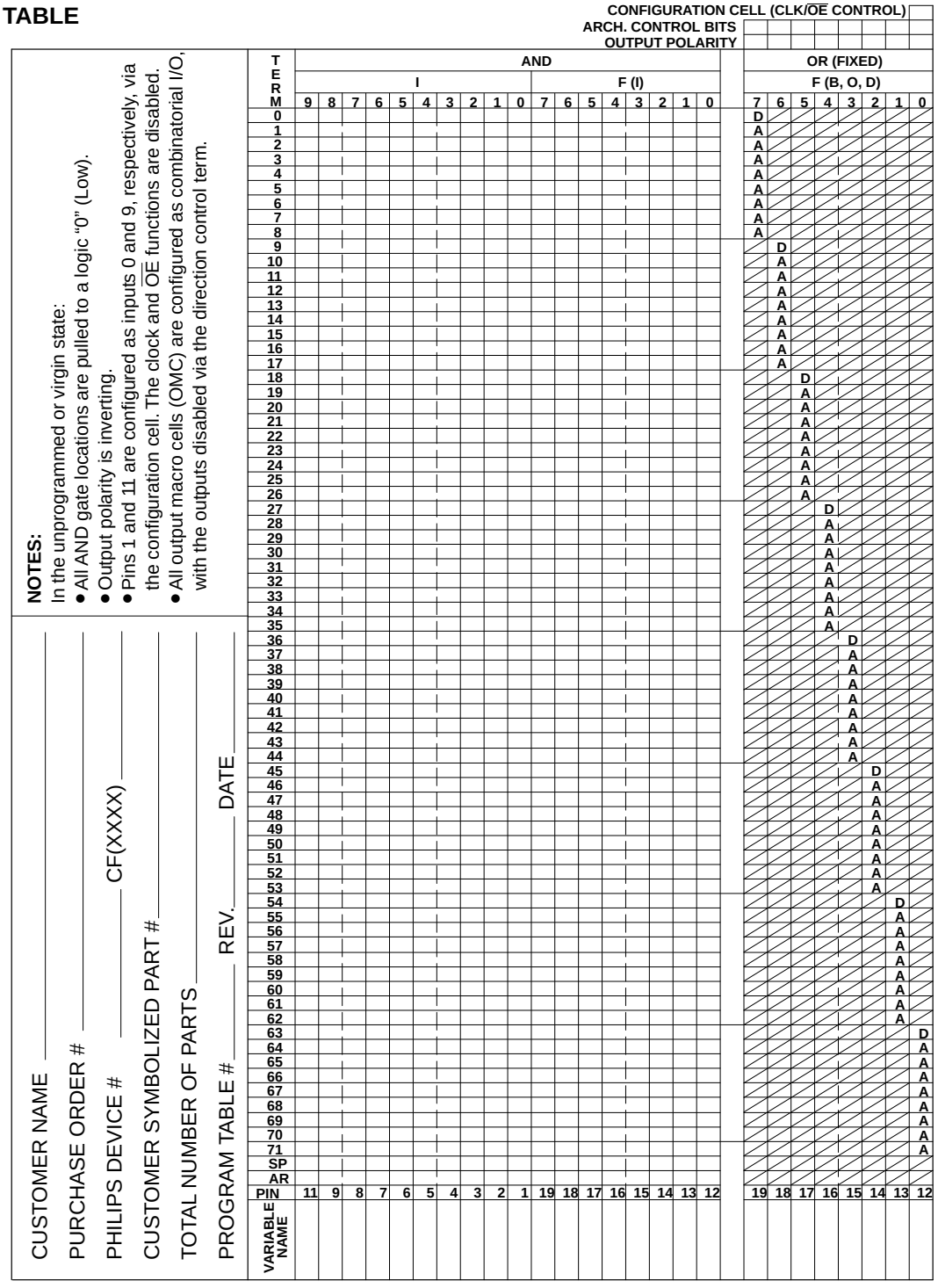
STATE	CODE
I, B	H

STATE	CODE
$\overline{I}$, $\overline{B}$	L

NOTE:
1. A factory shipped unprogrammed device is configured such that all cells are in a conductive state.

ABEL is a trademark of Data I/O Corp.
CUPL is a trademark of Logical Devices, Inc.

PROGRAM TABLE



AND ARRAY	
INACTIVE	O
I, F (I, B)	H
I, F (I, B)	L
**DON'T CARE	–

CONTROL	
OMC ARCH.	
REGISTERED (D-TYPE)	D
FIXED INPUT	I
FIXED OUTPUT	O
BIDIRECTIONAL I/O	B

OUTPUT POLARITY	
NON-INVERTING	H
INVERTING	L

CONFIG. CELL*	
PIN 1 = CLK; PIN 11 = $\overline{OE}$	L
PIN 1, PIN 11 = INPUT	H

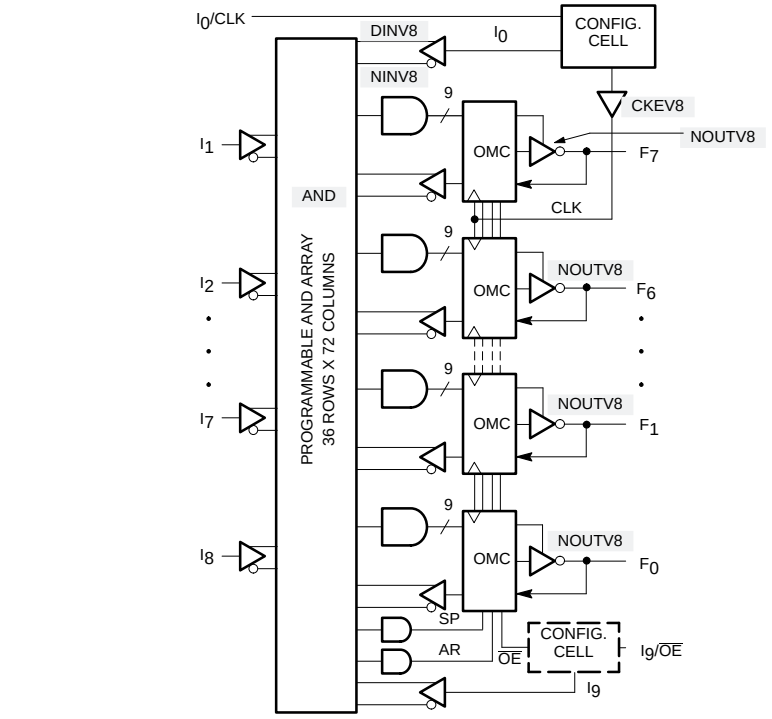
OR ARRAY (FIXED)	
DATA CANNOT BE ENTERED INTO THE OR ARRAY FIELD DUE TO THE FIXED NATURE OF THE DEVICE ARCHITECTURE.	
DIRECTION CONTROL	D
ACTIVE OUTPUT	A
NOT USED	

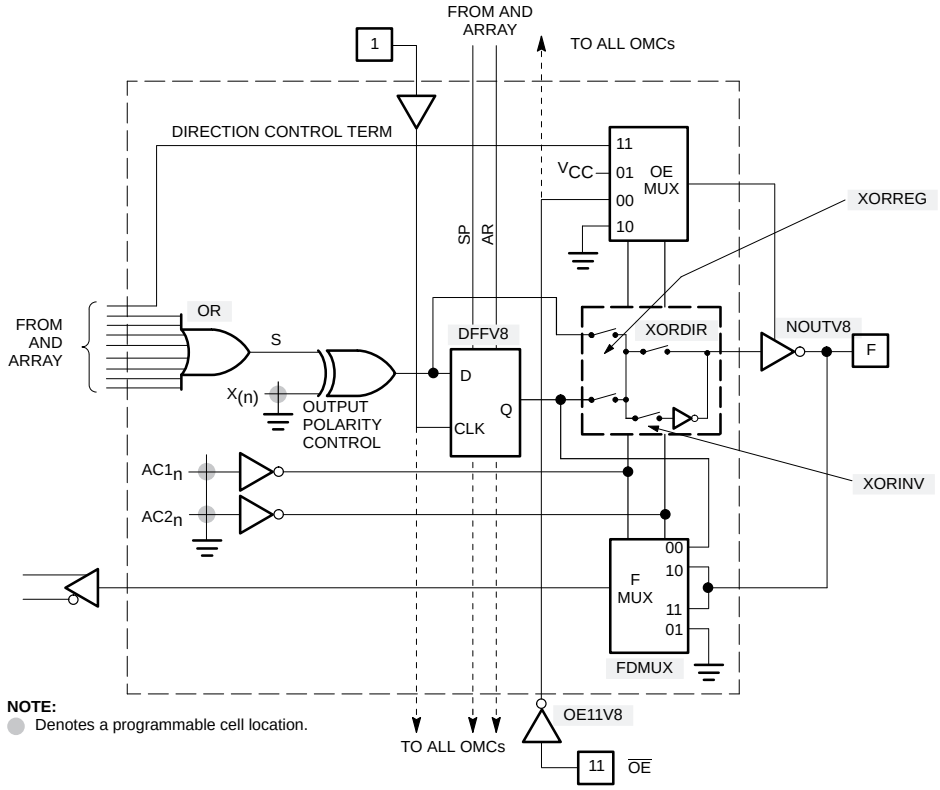
*** THE CONFIGURATION CELL IS AUTOMATICALLY PROGRAMMED BASED ON THE OMC ARCHITECTURE.**

**** FOR SP, AR: "–" IS NOT ALLOWED.**

SP00029

SNAP RESOURCE SUMMARY DESIGNATIONS

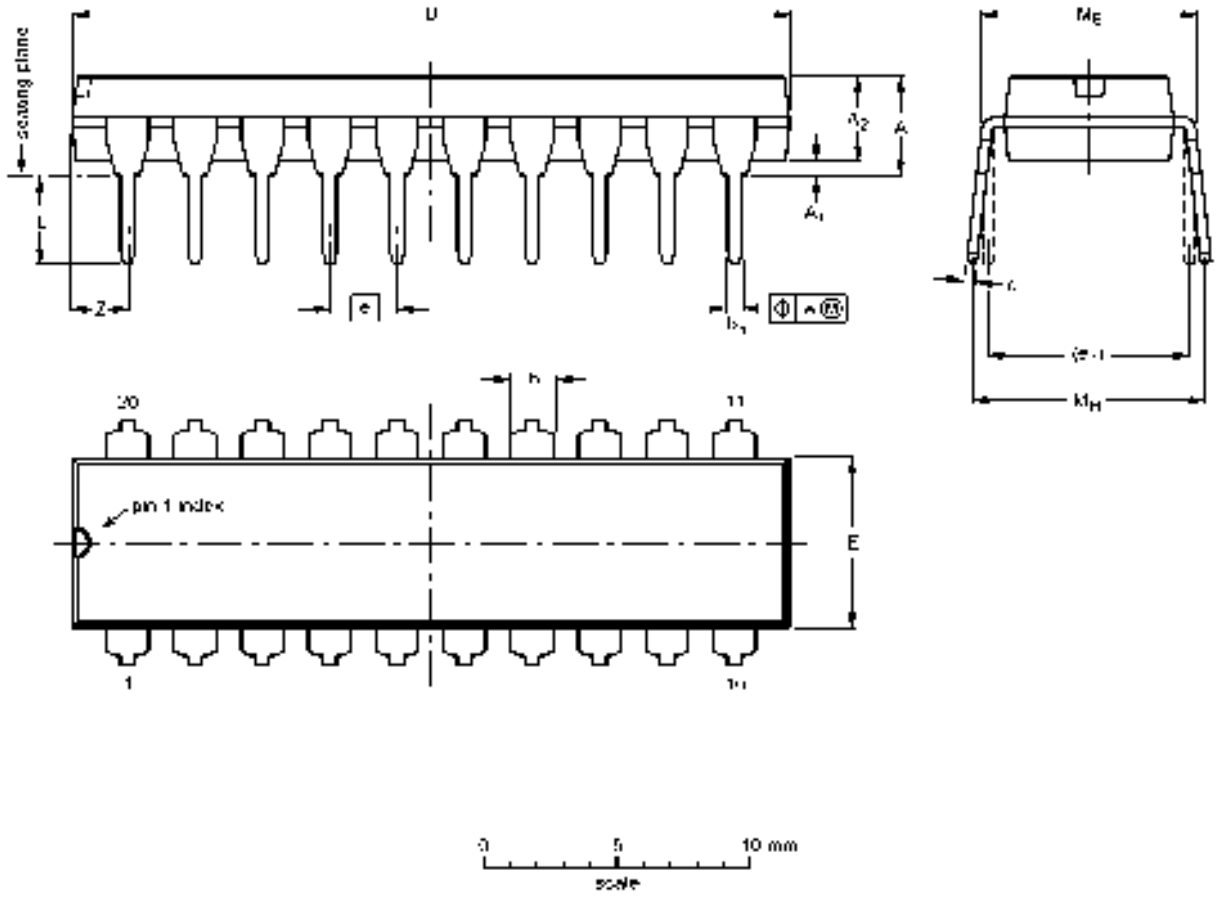




NOTE:
Denotes a programmable cell location.

SP00025

DIP20: plastic dual in-line package; 20 leads (300 mil) **SOT146-1**



DIMENSIONS (inch dimensions are derived from the original mm dimensions)

UNIT	A max.	A_1 min.	A_2 max.	b	b_1	c	D [1]	E [1]	e	M_E	M_H	w	Z [1] max.
mm	4.2	0.51	3.2	1.73 1.30	0.53 0.38	0.36 0.23	26.92 26.54	6.40 6.22	2.54	7.62	3.60 3.05	8.25 7.80	10.0 8.3	0.254	2.0
inches	0.17	0.020	0.13	0.068 0.051	0.021 0.015	0.014 0.009	1.060 1.045	0.25 0.24	0.10	0.30	0.14 0.12	0.32 0.31	0.39 0.33	0.01	0.078

Note

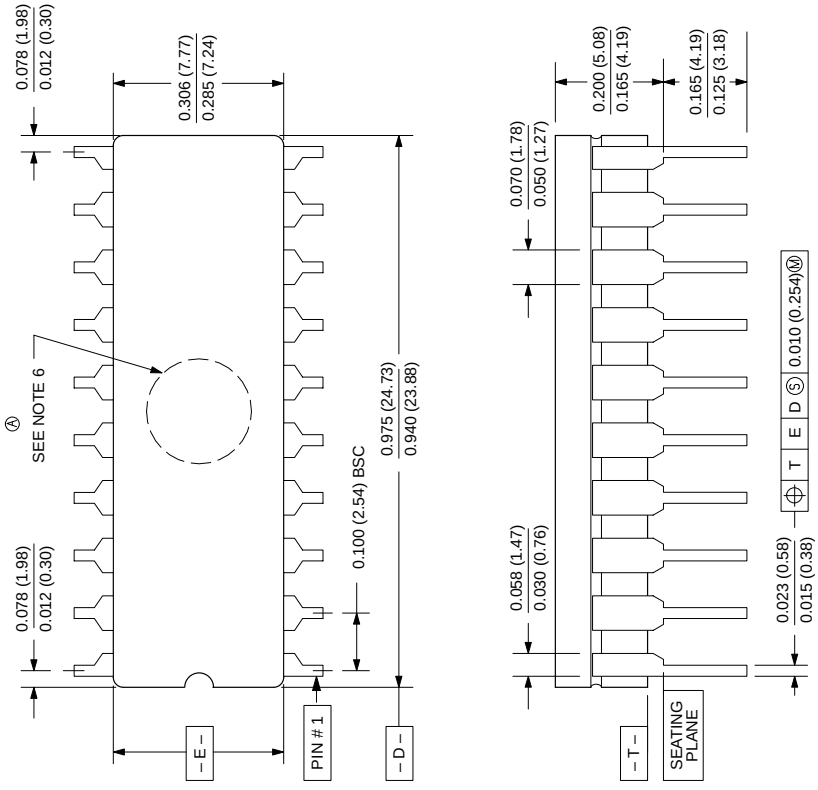
1. Plastic or metal protrusions of 0.25 mm maximum per side are not included.

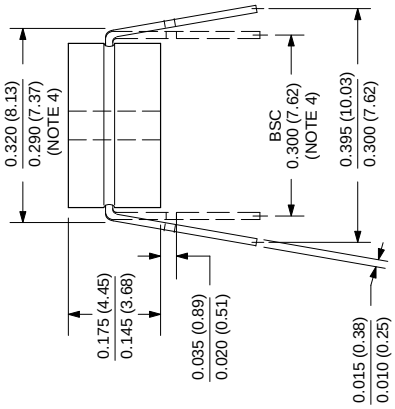
OUTLINE VERSION	REFERENCES				EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	EIAJ			
SOT146-1			SC603			92-11-17 95-05-24

0584B 20-PIN (300 mils wide) CERAMIC DUAL IN-LINE (F) PACKAGE (WITH WINDOW (FA) PACKAGE)

NOTES:

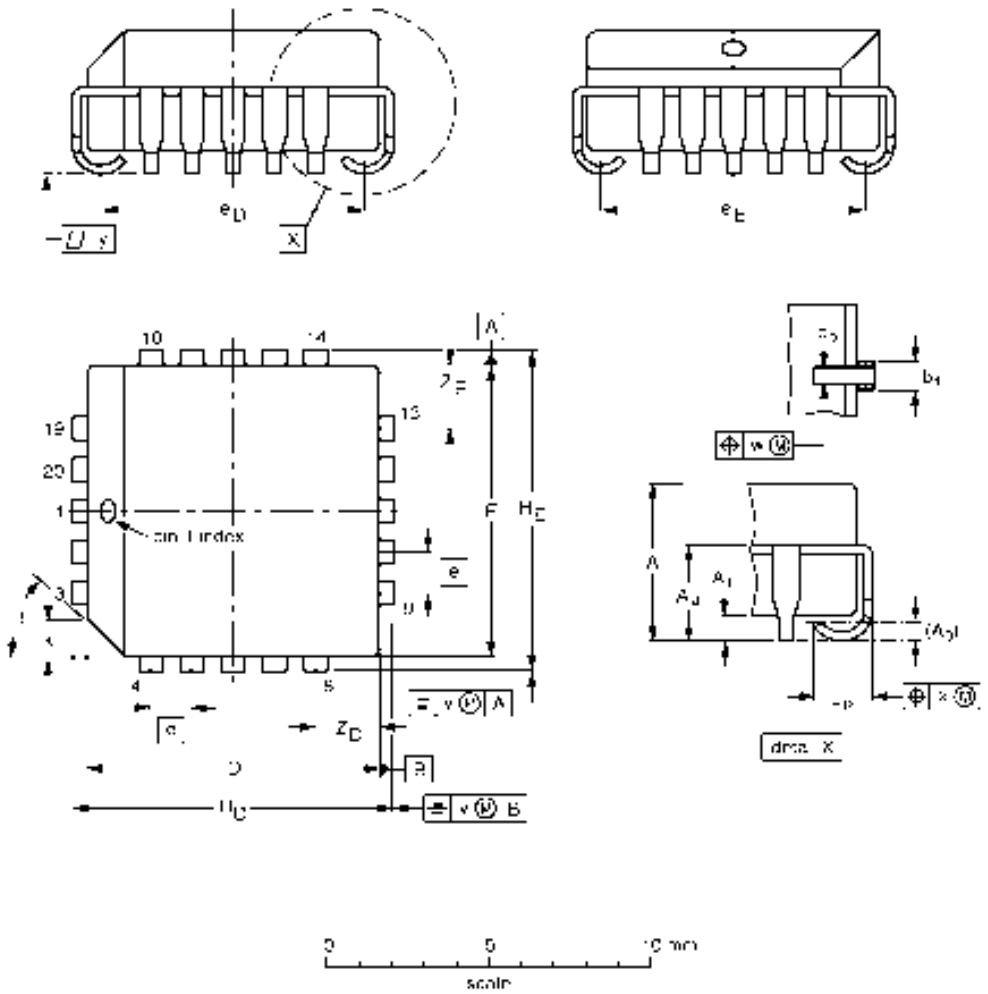
1. Controlling dimension: Inches. Millimeters are shown in parentheses.
2. Dimension and tolerancing per ANSI Y14. 5M-1982.
3. "T", "D", and "E" are reference datums on the body and include allowance for glass overrun and meniscus on the seal line, and lid to base mismatch.
4. These dimensions measured with the leads constrained to be perpendicular to plane T.
5. Pin numbers start with Pin #1 and continue counterclockwise to Pin #20 when viewed from the top.
6. Ⓐ Denotes window location for EPROM products.





853–0584B 06688

PLCC20: plastic leaded chip carrier; 20 leads **SOT380-1**



DIMENSIONS (millimetre dimensions are derived from the original inch dimensions)

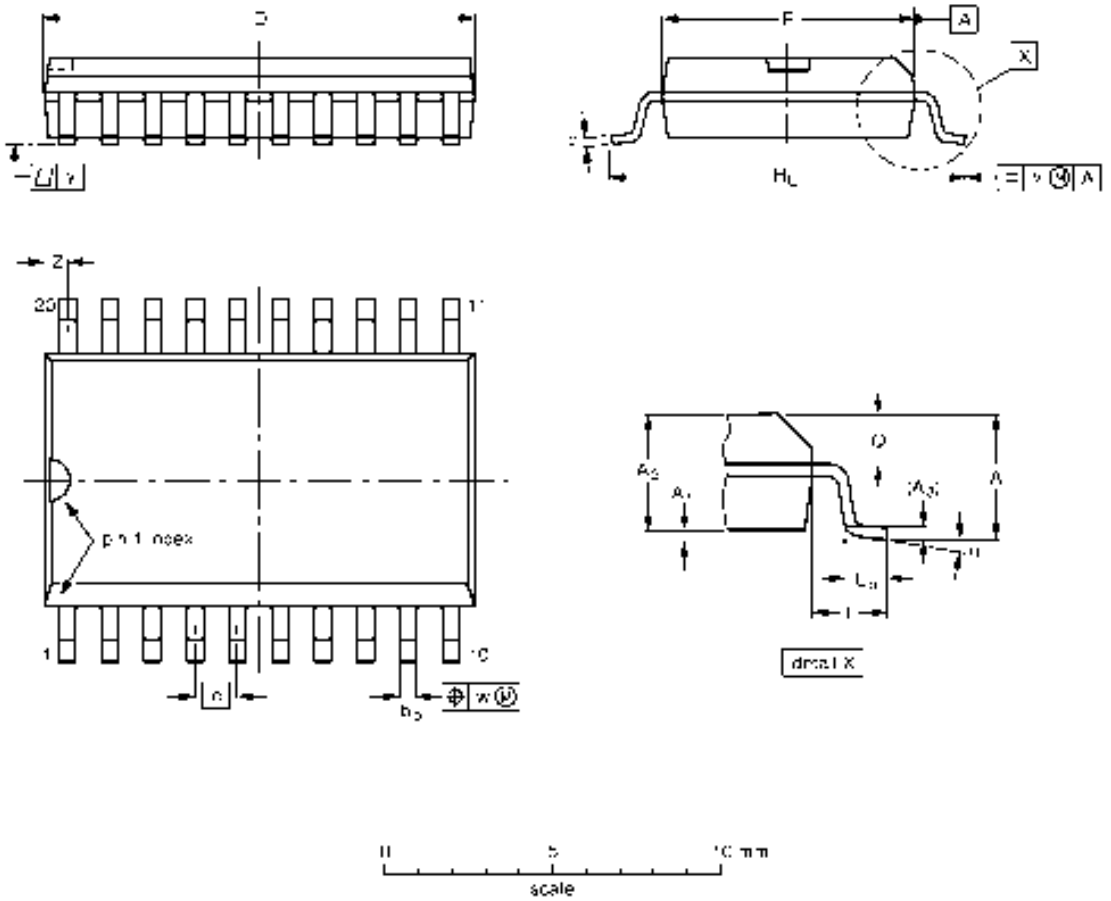
UNIT	A	A_1 min.	A_3	A_4 max.	b_p	b_1	D[1]	E[1]	e	e_D	e_E	H_D	H_E	k	L_p	v	w	y	Z_D[1] max.	Z_E[1] max.	θ
mm	4.57 4.19	0.51	0.25	3.05	0.53 0.33	0.81 0.66	9.91 9.65	9.91 9.65	1.27	8.89 7.37	8.76 7.77	10.03 9.78	10.03 9.78	1.22 1.07	1.44 1.02	0.18	0.18	0.10	2.16	2.16	45°
inches	0.180 0.165	0.020	0.01	0.12	0.021 0.013	0.032 0.026	0.390 0.380	0.390 0.380	0.05	0.350 0.290	0.345 0.305	0.395 0.385	0.395 0.385	0.048 0.042	0.057 0.040	0.007	0.007	0.004	0.085	0.085	

Note

1. Plastic or metal protrusions of 0.01 inches maximum per side are not included.

OUTLINE VERSION	REFERENCES			EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	EIAJ		
SOT380-1		MO-047AA			95-03-25

SO20: plastic small outline package; 20 leads; body width 7.5 mm **SOT163-1**



DIMENSIONS (inch dimensions are derived from the original mm dimensions)

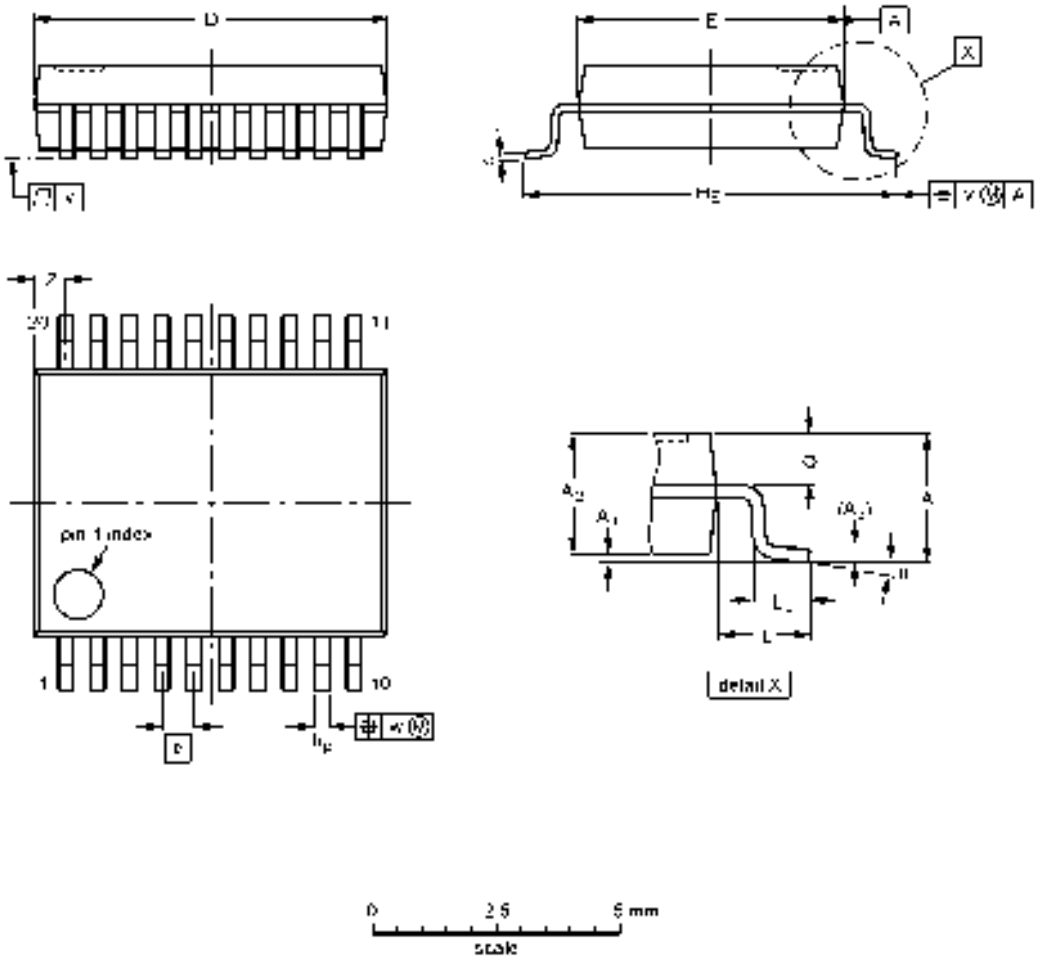
UNIT	A max.	A_1	A_2	A_3	b_p	c	D[1]	E[1]	e	H_E	L	L_p	Q	v	w	y	$Z^{(1)}$	θ
mm	2.65	0.30 0.10	2.45 2.25	0.25	0.49 0.35	0.32 0.23	13.0 12.6	7.6 7.4	1.27	10.65 10.00	1.4	1.1 0.4	1.1 1.0	0.25	0.25	0.1	0.9 0.4	8° 0°
inches	0.10	0.012 0.004	0.096 0.089	0.01	0.019 0.014	0.013 0.009	0.51 0.49	0.30 0.29	0.050	0.42 0.39	0.055	0.043 0.016	0.043 0.039	0.01	0.01	0.004	0.035 0.016	

Note

1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.

OUTLINE VERSION	REFERENCES				EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	EIAJ			
SOT163-1	075E04	MS-013AC				92-11-17 95-01-24

SSOP20: plastic shrink small outline package; 20 leads; body width 5.3 mm **SOT339-1**



DIMENSIONS (mm are the original dimensions)

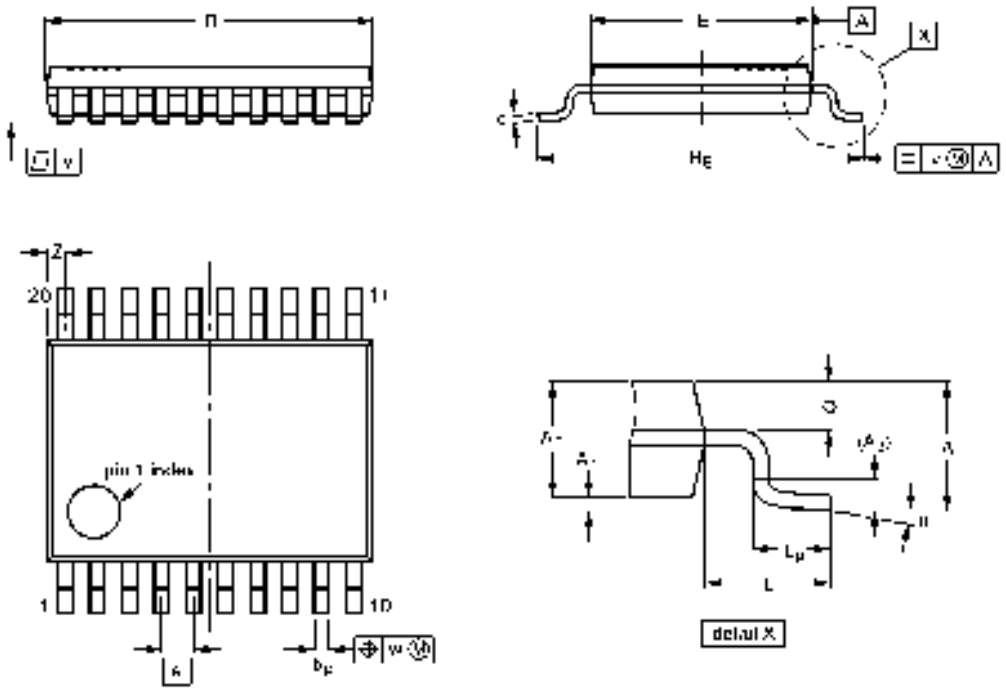
UNIT	A max	A_1	A_2	A_3	b_p	c	D[1]	E[1]	e	H_E	L	L_p	Q	v	w	y	Z[1]	θ
mm	2.0	0.21 0.05	1.80 1.65	0.25	0.38 0.25	0.20 0.09	7.4 7.0	5.4 5.2	0.65	7.9 7.6	1.25	1.03 0.63	0.9 0.7	0.2	0.13	0.1	0.9 0.5	8° 0°

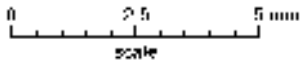
Note

1. Plastic or metal protrusions of 0.20 mm maximum per side are not included.

OUTLINE VERSION	REFERENCES				EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	EIAJ			
SOT339-1		MO-150AE				93-05-06 95-02-04

TSSOP20: plastic thin shrink small outline package; 20 leads; body width 4.4 mm SOT360-1





DIMENSIONS (mm are the original dimensions)

UNIT	A max.	A_1	A_2	A_3	b_p	c	D[1]	E[2]	e	H_E	L	L_p	Q	v	w	y	Z[1]	θ
mm	1.10	0.15 0.05	0.85 0.80	0.25	0.30 0.19	0.2 0.1	6.6 6.4	4.5 4.3	0.65	6.6 6.2	1.0	0.75 0.50	0.4 0.3	0.2	0.13	0.1	0.5 0.2	8° 0°

Notes

1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.
2. Plastic interlead protrusions of 0.25 mm maximum per side are not included.

OUTLINE VERSION	REFERENCES				EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	EIAJ			
SOT360-1		MO-153AC				93-06-16 95-02-04

NOTES

DEFINITIONS

Data Sheet Identification	Product Status	Definition
Objective Specification	Formative or in Design	This data sheet contains the design target or goal specifications for product development. Specifications may change in any manner without notice.
Preliminary Specification	Preproduction Product	This data sheet contains preliminary data, and supplementary data will be published at a later date. Philips Semiconductors reserves the right to make changes at any time without notice in order to improve design and supply the best possible product.
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